### April 2001

## FDC645N N-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

SEMICONDUCTOR IM

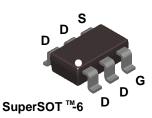
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(ON)}$  and fast switching speed.

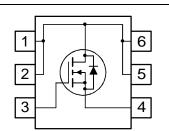
### Applications

• DC/DC converter

### Features

- 5.5 A, 30 V.  $R_{DS(ON)} = 30 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 26 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- Low gate charge (13 nC typical)
- High power and current handling capability





### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol		Parameter	Ratings	Units		
V <sub>DSS</sub>	Drain-Source Voltage			30	V	
V <sub>GSS</sub>	Gate-Source Voltage			±12	V	
ID	Drain Curre	nt – Continuous	(Note 1a)	5.5	A	
		<ul> <li>Pulsed</li> </ul>		20		
P <sub>D</sub>	Maximum Power Dissipation (Note 1a) 1.6		1.6	W		
			(Note 1b)	0.8		
T <sub>J</sub> , T <sub>STG</sub>	Operating a	nd Storage Junction T	-55 to +150			
Therma	I Charac	teristics				
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)			78	°C/W	
R <sub>0JC</sub>	Thermal Resistance, Junction-to-Case (Note 1)			30	°C/W	
		g and Orderin	g Information Reel Size	Tape width	Quantity	
.645		FDC645N	7"		3000 units	

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FDC645N

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 µA, Referenced to 25°C		22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -12 V, V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.8	1.4	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		- 4		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance			25 23 34	30 26 48	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	20			Α
<b>g</b> fs	Forward Transconductance	$V_{DS} = 10 V$ , $I_D = 5.5 A$		33		S
Dvnamio	Characteristics					
Ciss	Input Capacitance $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$			1460		pF
Coss	Output Capacitance	f = 1.0 MHz		227		pF
Crss	Reverse Transfer Capacitance			96		pF
Switchin	g Characteristics (Note 2)		•	•	•	•
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DS} = 15 V$ , $I_D = 1 A$ ,		8	16	ns
tr	Turn–On Rise Time	$V_{GS} = 4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		9	18	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			35	56	ns
t <sub>f</sub>	Turn–Off Fall Time			7	14	ns
Qg	Total Gate Charge	$V_{DS} = 15 V, I_D = 6.2 A,$		13	21	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 4.5 V$		3.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	7		3.6		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings			•	
ls	Maximum Continuous Drain–Source				1.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 1.3 A$ (Note 2)		0.7	1.2	V

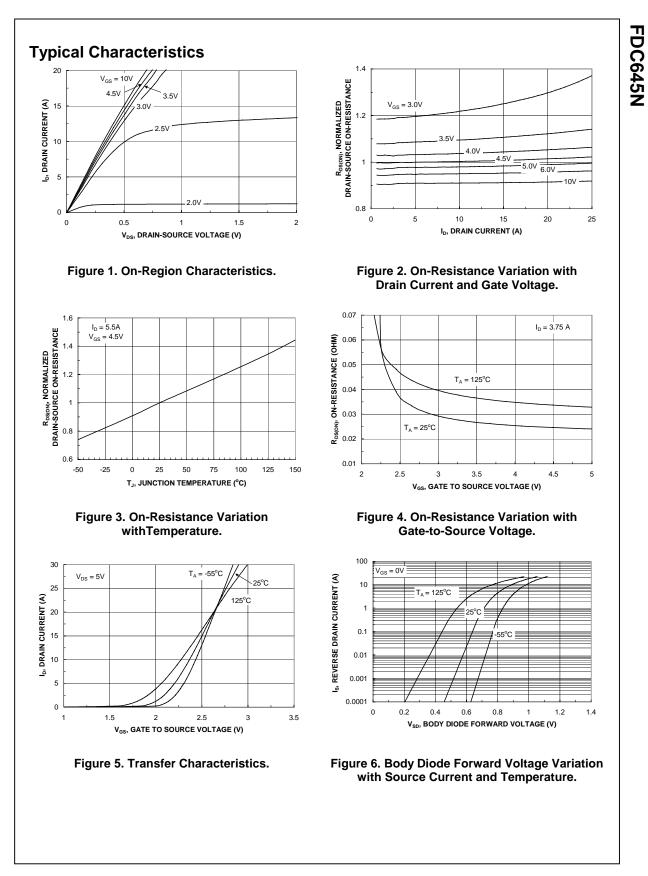
Notes:

1. R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.

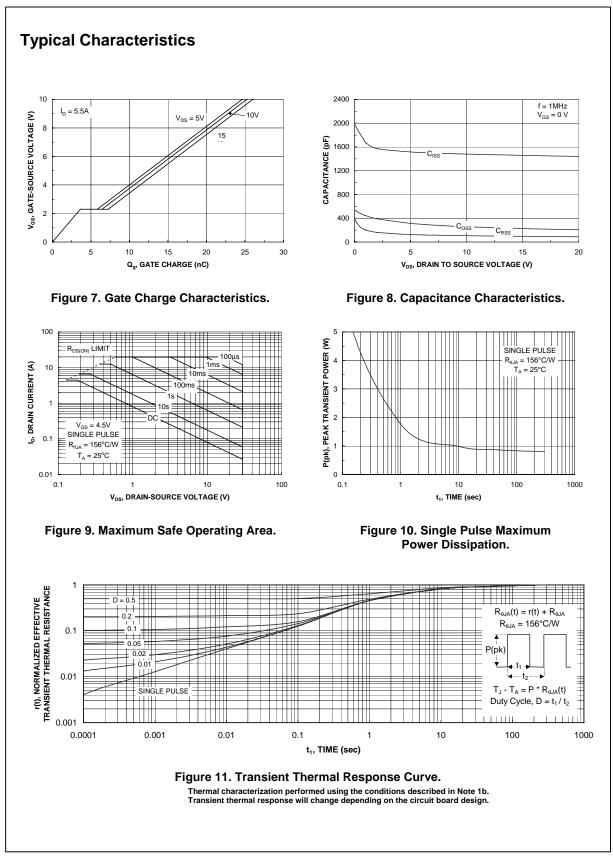
a.  $~78^\circ\text{C/W}$  when mounted on a  $1\text{in}^2$  pad of 2oz copper on FR-4 board.

b. 156°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width  $\leq 300~\mu s,$  Duty Cycle  $\leq 2.0\%$ 



FDC645N Rev C(W)



# FDC645N

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